SHEET_1 OF 1 FORM PTO-1449 U.S. Department of Commerce (Rev. 4/92) Patent and Trademark Office ATTY, DOCKET NO. SERIAL NO. 10/521,243 L9289.04196 (Use several sheets if necessary) APPLICANT **Kenichiro SHINOI** FILING DATE January 14, 2005 **GROUP** 2155 **U.S. PATENT DOCUMENTS** EXAMINER IF ALLENS PATETE **DOCUMENT NUMBER** DATE NAME CLASS 6UBCLASS ナン 7 0 5 0 6 1 05/2006 Hamabe FOREIGN PATENT DOCUMENTS DOCUMENT NUMBER COUNTRY SUBCLASS' CLASS TRANSLATION YES NO エン 2002 2 3 9 09/2002 JP **Abstract** OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.) Japanese Office Action with English translation for Japanese Patent Application No. 2003-122544 dated July 17, 2007. ナ・ハ

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